

# Accreditation



The Deutsche Akkreditierungsstelle attests with this **Partial Accreditation Certificate** that the testing laboratory

**VDE Prüf- und Zertifizierungsinstitut GmbH**  
**Merianstraße 28, 63069 Offenbach, Germany**

meets the requirements according to DIN EN ISO/IEC 17025:2018 for the conformity assessment activities listed in the annex to this certificate. This includes additional existing legal and normative requirements for the testing laboratory, including those in relevant sectoral schemes, provided they are explicitly confirmed in the annex to this certificate.

The management system requirements of DIN EN ISO/IEC 17025 are written in the language relevant to the operations of testing laboratories and they conform to the principles of DIN EN ISO 9001.

This accreditation was issued in accordance with Art. 5 Para. 1 Sentence 2 of Regulation (EC) 765/2008, after an accreditation procedure was carried out in compliance with the minimum requirements of DIN EN ISO/IEC 17011 and on the basis of a review and decision of the appointed accreditation committees.

This partial accreditation certificate only applies in connection with the notice of 01.07.2024 with accreditation number D-PL-12061-01.

It consists of this cover sheet, the reverse side of the cover sheet and the following annex with a total of 29 pages.

Registration number of the partial accreditation certificate: **D-PL-12061-01-02**

It is a part of the accreditation certificate: D-PL-12061-01-00.

Berlin, 01.07.2024

Florian Burkart  
Head of Technical Unit

Translation issued:  
13.11.2024

  
Florian Burkart  
Head of Technical Unit

*The certificate together with the annex reflects the status as indicated by the date of issue. The current status of any given scope of accreditation can be found in the directory of accredited bodies maintained by Deutsche Akkreditierungsstelle GmbH ([www.dakks.de](http://www.dakks.de)).*

This document is a translation. The definitive version is the original German accreditation certificate.

See notes overleaf